

Search Notes

Application/Control No.

10/541,322

Examiner

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Applicant(s)/Patent under Reexamination

OHUCHI ET AL.

Art Unit

2856

SEARCHED

Class	Subclass	Date	Examiner
74	504.16	4/26/2006	HK
73	504.12	4/26/2006	HK
73	504.04	4/26/2006	HK
310	329	4/26/2006	HK
310	370	4/26/2006	HK
310	316	4/26/2006	HK
310	317	4/26/2006	HK
310	357-360	4/26/2006	HK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner